

Search Notes

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Examiner

Patrick T. Lewis

Applicant(s)/Patent under
Reexamination

ECKL ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Structure and Inventor search by STIC (Suppl. Content)	10/26/2007	PL